D<sup>2</sup>PAK (TO-263)



## SPB21N50C3-VB Datasheet

## N-Channel 650 V (D-S) Super Junction MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V) at T <sub>J</sub> max.	650					
R <sub>DS(on)</sub> (Ω) at 25 °C	$V_{GS} = 10 V$	0.19				
Q <sub>g</sub> max. (nC)	106					
Q <sub>gs</sub> (nC)	14					
Q <sub>gd</sub> (nC)	33					
Configuration	Single					

#### **FEATURES**

- Reduced t<sub>rr</sub>, Q<sub>rr</sub>, and I<sub>RRM</sub>
- Low figure-of-merit (FOM) Ron x Qq
- Low input capacitance (Ciss)
- Low switching losses due to reduced Q<sub>rr</sub>
- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)

#### **APPLICATIONS**

- Telecommunications
  - Server and telecom power supplies
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Consumer and computing
- ATX power supplies
- Industrial
  - Welding
  - Battery chargers
- Renewable energy
  - Solar (PV inverters)
- Switch mode power supplies (SMPS)

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_c = 25 \degree C$ , unless otherwise noted)									
PARAMETER			SYMBOL	LIMIT	UNIT				
Drain-Source Voltage			V <sub>DS</sub>	650	- V				
Gate-Source Voltage			V <sub>GS</sub>	± 30	v				
Continuous Drain Current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 10 V T <sub>C</sub> =	= 25 °C : 100 °C		20					
	$V_{GS}$ at 10 V $T_{C} =$	: 100 °C	Ι <sub>D</sub>	13	A				
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	60					
Linear Derating Factor				1.7	W/°C				
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	367	mJ				
Maximum Power Dissipation			PD	208	W				
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C				
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C		dV/dt	37	V/ns				
Reverse Diode dV/dt <sup>d</sup>			av/dt	31	v/ns				
Soldering Recommendations (Peak Temperature) <sup>c</sup>	for 10 s			300	°C				

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD} = 50$  V, starting T<sub>J</sub> = 25 °C, L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 5.1 A.

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c. 1.6 mm from case.

d.  $I_{SD} \leq I_D$ , dl/dt = 100 A/µs, starting  $T_J$  = 25 °C.





THERMAL RESISTANCE RAT	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		62				
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 0.5				°C/W		
SPECIFICATIONS (T <sub>J</sub> = 25 $^{\circ}$ C, u	unless otherwi	se noted)						
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static	•	•						<u> </u>
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> =	250 µA	650	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, $I_D = 1 \text{ mA}$		-	0.67	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> =	250 µA	2	-	4	V
Cata Sauraa Laakaga		$V_{GS} = \pm 20 V$ $V_{GS} = \pm 30 V$		-	-	± 100	nA	
Gate-Source Leakage	IGSS			-	-	± 1	μA	
Zero Gate Voltage Drain Current	L_	V <sub>DS</sub> =	V <sub>DS</sub> = 520 V, V <sub>GS</sub> = 0 V		-	-	1	
	I <sub>DSS</sub>	V <sub>DS</sub> = 520 V	$V_{\rm GS} = 0$	V, T <sub>J</sub> = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 V$	I	<sub>D</sub> = 11 A	-	0.19	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	= 30 V, I <sub>D</sub>	= 11 A	-	7.0	-	S
Dynamic		-			-	-	-	
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,		-	2322	-	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 100 V,$ f = 1 MHz		-	105	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	4	-		
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	$V_{DS}$ = 0 V to 520 V, V <sub>GS</sub> = 0 V		-	84	-		
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	293	-		
Total Gate Charge	Qg	V <sub>GS</sub> = 10 V I <sub>D</sub> = 11 A, V <sub>DS</sub> = 520 V		-	71	106	nC	
Gate-Source Charge	Q <sub>gs</sub>			-	14	-		
Gate-Drain Charge	Q <sub>gd</sub>				-	33	-	1
Turn-On Delay Time	t <sub>d(on)</sub>	•		-	22	44		
Rise Time	t <sub>r</sub>		V <sub>DD</sub> = 520 V, I <sub>D</sub> = 11 A,		-	34	68	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ = 10 V, $R_g$ = 9.1 $\Omega$		-	68	102	ns	
Fall Time	t <sub>f</sub>			-	42	84		
Gate Input Resistance	R <sub>g</sub>	f = 1 MHz, open drain		-	0.78	-	Ω	
Drain-Source Body Diode Characteristi	cs							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	21	A	
Pulsed Diode Forward Current	I <sub>SM</sub>			-	-	53		
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 11 A, V <sub>GS</sub> = 0 V		-	0.9	1.2	V	
Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = I_S = 11 \text{ A},$ dl/dt = 100 A/µs, V <sub>R</sub> = 25 V		-	160	-	ns	
Reverse Recovery Charge	Q <sub>rr</sub>			-	1.2	-	μC	
Reverse Recovery Current	I <sub>RRM</sub>			-	14	-	A	

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

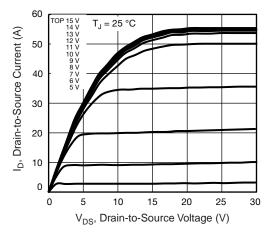


Fig. 1 - Typical Output Characteristics



Fig. 2 - Typical Output Characteristics

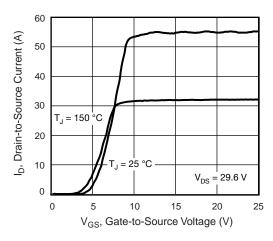


Fig. 3 - Typical Transfer Characteristics

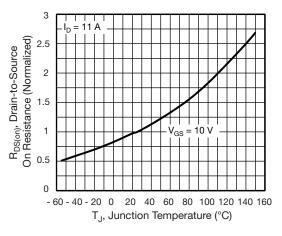


Fig. 4 - Normalized On-Resistance vs. Temperature

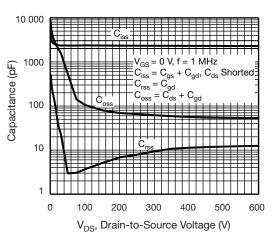


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

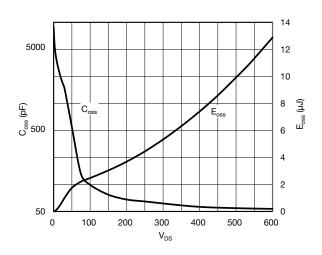


Fig. 6 -  $C_{oss}$  and  $E_{oss}$  vs.  $V_{DS}$ 

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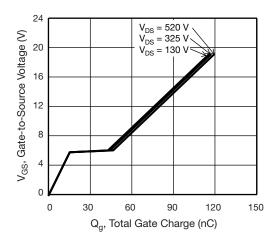


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

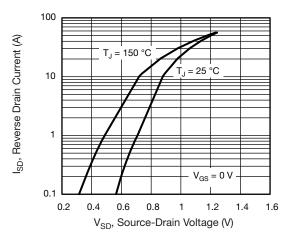


Fig. 8 - Typical Source-Drain Diode Forward Voltage

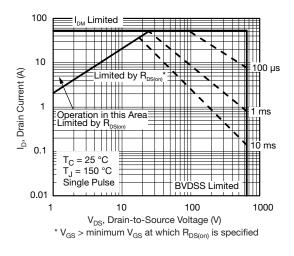


Fig. 9 - Maximum Safe Operating Area

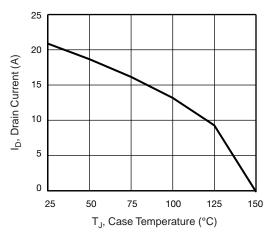


Fig. 10 - Maximum Drain Current vs. Case Temperature

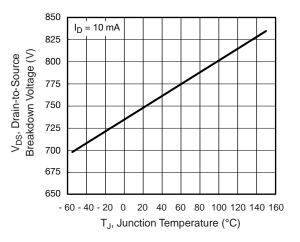


Fig. 11 - Temperature vs. Drain-to-Source Voltage





Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case



Fig. 13 - Switching Time Test Circuit



Fig. 14 - Switching Time Waveforms



Fig. 15 - Unclamped Inductive Test Circuit

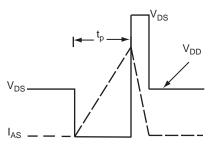


Fig. 16 - Unclamped Inductive Waveforms

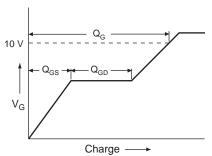


Fig. 17 - Basic Gate Charge Waveform

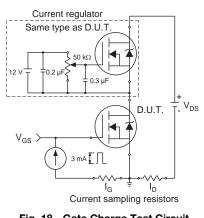
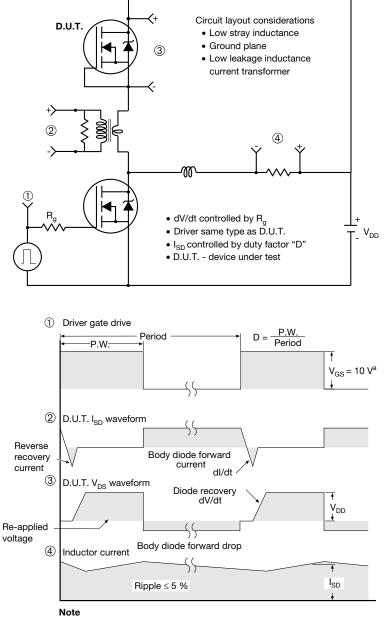


Fig. 18 - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit

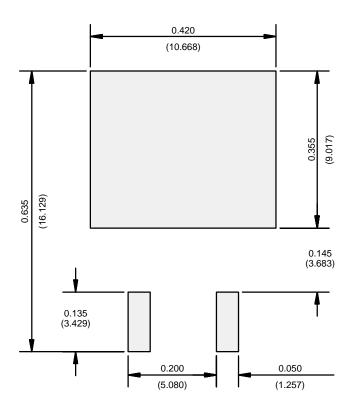


a.  $V_{GS} = 5$  V for logic level devices

Fig. 19 - For N-Channel



## **RECOMMENDED MINIMUM PADS FOR D<sup>2</sup>PAK: 3-Lead**



Recommended Minimum Pads Dimensions in Inches/(mm)



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